

Notice of References Cited	Application/Control No. 10/033,143	Applicant(s)/Patent Under Reexamination WARTH ET AL.	
	Examiner Tae H Yoon	Art Unit 1714	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,534,379	07-1996	Dalal et al.	430/108.8
	B	US-6,111,016	08-2000	Katayama et al.	525/92E
	C	US-6,348,527	02-2002	Nodera, Akio	524/127
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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